Comparison of Laser Performance for Diode-Pumped Tm:YLF of Various Doping Concentrations

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Abstract: Single-end-pumped laser performance of 2, 4, and 6at.% Tm-doped YLF rods is reported. For the pumping configuration employed, crystal fracture was observed to occur for a thermal load per unit absorption length of ~13W/cm. The 2at.% Tm-doped crystal was found to have a quantum yield of ~90% of that of 4at.% Tm. However, due to a lower thermal loading density, the maximum possible incident pump power is predicted to be >60% higher, hence offering a greater output power per rod for the lower doping concentration. Power scaling considerations are discussed with reference to cross-relaxation, upconversion, and thermal loading of the host crystal.

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Introduction

Two-micron Tm$^{3+}$ lasers are of interest for many applications in the scientific, defence, and medical fields. Thulium readily substitutes into many crystal hosts that are suitable for high-average-power laser systems and it has an absorption band at ~0.8μm allowing excitation with commercially available high-power laser diodes [1]. Thulium-doped YLF has been investigated by several groups, with several tens of Watts being reported by Budni et. al. [2], and Dergachev et. al. [3], in end- and side-pumped configurations respectively. YLF, although recognised as a good laser host for its spectroscopic properties, is a relatively fragile crystal with a low stress-fracture limit. Thermally-induced fracture has been reported to occur when end-pumping Tm:YLF with 792nm diodes and beam-waist pump intensities of >5kWcm$^{-2}$ [2]. This limit can be increased by ~60% via the use of diffusion bonded undoped end caps [4]. Alternatively, for power scaling, reducing the doping concentration of the host crystal and thus the absorption coefficient, albeit with higher demands on the pump-source brightness, leads to smaller temperature excursions and thus reduces stress on the rod-air interface. However, in the case of Tm-doped solid-state lasers there are conflicting requirements since at high doping levels Tm lasers benefit from an increase in the quantum efficiency due to the ‘two-for-one’ cross-relaxation (self-quenching) process, $^{3}F_4$, $^{3}H_6 \rightarrow ^{3}H_4$, which becomes less efficient as the Tm concentration is reduced leading to a reduction in the slope efficiency and increased thermal loading.

Another important factor to consider is the three-level-nature of Tm:YLF when operating in the 2μm regime, which requires that ~10% of the lower manifold population is excited into the upper laser level to obtain transparency at the lasing wavelength. One consequence of large excited-state population densities is the exacerbation of energy-transfer-upconversion (ETU), which reduces the upper laser level lifetime and thus increases laser threshold. This process is also dependent on the density of the excited Tm ions and therefore the concentration and pump intensity. Furthermore, ETU contributes to the amount of heat generated in the crystal, thereby impacting on the stress in the laser crystal, the lower laser level population density, and consequently the required population inversion. The spectroscopic ETU rate parameters can be determined directly as a function of the Tm$^{3+}$ doping concentration from a measurement of the fluorescence decay from the upper level. However more useful information for the laser designer can be obtained directly from a simple comparative study of the performance of Tm:YLF
lasers with different Tm concentrations, since this encapsulates all the inter-dependent processes. Ultimately therefore, when choosing a Thulium concentration there is a trade-off between the beneficial cross-relaxation, detrimental ETU, and thermal loading density within the laser crystal.

To allow a strategy to be formulated for scaling of Tm:YLF laser powers requires knowledge of several key design parameters, of which there are few to be found in the literature. Reported here are preliminary findings of a comparative study of laser performance for singly-end-pumped Tm:YLF rods with a range of doping concentrations.

Experimental set-up

The 3mm diameter (a-cut) Tm:YLF laser rods investigated in our study were doped with 2, 4, and 6 at.% Tm$^{3+}$. Both end faces of the rods were antireflection coated for pump and lasing wavelengths at 792nm and ~1.9µm respectively, and the rod lengths were selected to be two absorption lengths at the pump wavelength (i.e. 24mm, 12mm, and 8mm respectively). All rods were mounted in water-cooled copper blocks to allow effective heat removal whilst pumped by high-power diode-laser arrays.

For this study a simple two-mirror resonator configuration was employed, comprising a plane pump in-coupling mirror with high reflectivity at the lasing wavelength and high transmission at the pump wavelength, and a concave output coupler with a 200mm radius of curvature. A cavity length of 100-120mm was selected to produce a calculated average TEM$_{oo}$ beam radius in the YLF crystal (under unpumped conditions) of ~260µm, which was expected to increase by up to 50% at the maximum available pump power due to the effect of the weak negative thermal lensing in Tm:YLF. The pump beam was focussed to a waist radius, $w_p \approx 460$µm, roughly equal to that required for confocal pumping of the 2at.% rod (i.e. $w_p = (M^2\lambda L/2\pi n)^{1/2}$) and positioned approximately at the mid-point of each laser rod respectively. In this way all of the Tm:YLF lasers were deliberately operated in a multi-transverse mode regime and under the same conditions, as such the effects of thermally-induced lens aberration on output power and efficiency were minimised, and a relative comparison between the performance for each doping concentration could be made.

Two diode-laser pump sources were employed in this study (Fig. 1): the first consisted of two low-fill-factor water-cooled diode-bars and the second a 6-bar low-fill-factor diode stack. Each bar, for

Fig. 1: Experimental configuration with (a) diode-bar pumping and (b) diode-stack pumping.

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1 Impex High-Tech, Rheine, Germany
both of the sources, was collimated in the fast and slow-axes with micro-lenses. The single diode bars were then polarisation combined to produce a single beam. Two-mirror beam-shapers [5] were employed to re-format the beams with roughly equal beam-quality factors in the orthogonal planes. For the polarisation-coupled bars, the resulting beam-quality was $M_x^2 \approx 80$ (parallel to the array) and $M_y^2 \approx 52$ (perpendicular to the array) with a maximum power of ~52W. In contrast the final beam-shaped diode stack beam-quality was $M_x^2 \approx 160$ and $M_y^2 \approx 100$ with a maximum power of ~265W. A uniform pump distribution was desirable for these comparative studies, hence the output beam from the diode-bar pump source was ‘homogenised’ by coupling into a multi-mode fibre with a core diameter of 365μm and 0.22 NA. A spatial filter was used to reduce the $M^2$ value to ~100 allowing relatively tight pump focusing with minimal diffraction spreading even in the longest Tm:YLF rod under investigation, limiting the maximum available pump power to ~33W. To produce a similar beam-quality from the diode stacks, a spatial filtering slit was employed in the x-axis only, limiting the available incident power to ~115W, which was more than sufficient for our study.

**Results and Discussion**

Fig. 2(a) shows the output power versus incident pump power for all three Tm:YLF rods using a 13.5% output coupler. Less than 10% output coupling resulted in a longer operating wavelength away from the peak of the $\sigma$-polarised emission cross section at 1.91µm. A linear fit to the data points for pump powers greater than three times threshold has been used to calculate the slope efficiency thus providing a good basis for comparison when operating in the saturated regime. Similar performance curves are shown in Fig. 2(b) for diode-stack pumping, apart from the 6at.% crystal which fractured whilst diode-bar pumping at an incident pump power of 20.5W. Furthermore the fracture limit for the 4at.% crystal was found when diode-stack pumping at an incident power of 45.8W. The pump absorption efficiencies at threshold were ~82% and ~84% respectively for Fig. 2(a) and (b), this small difference can be attributed to the linearly-polarised output of the diode stack source in contrast to the “un-polarised” output from the fibre-coupled diode-bars.

The laser output was determined to be $\sigma$-polarised with a wavelength of 1.91 µm. Thermal lensing is known to be weaker for $\sigma$-polarised light in YLF crystals due to a lower value for $dn/dT$ than for the orthogonal $\pi$-polarisation. The weak nature of thermal lensing in the Tm:YLF laser is apparent, since there is no evidence of a thermally-induced roll-over in the output power.

As illustrated by Fig. 2, there is clearly a very pronounced effect of the Tm doping level on performance. Given that all three Tm:YLF rods were operated under nearly identical conditions in terms of cavity loss, pump beam and laser mode sizes and re-absorption loss, we can draw the following conclusions: (a) The difference in slope efficiency for the 2at% and 4at% Tm-doped rods is primarily due to a difference in the cross-relaxation efficiency. We can therefore conclude that the pumping quantum efficiency is approximately ~10% higher for the 4at% doping level than for the 2at.% doping level. (b) The difference in threshold pump power for the three rods is due to the combined effects of ETU and cross-relaxation. It is observed that the 2at.% and 4at.% Tm$^{3+}$ doped rods have comparable thresholds indicating that the higher cross-relaxation efficiency for the 4at.% Tm$^{3+}$ doped rod is offset by a higher loss due to ETU compared to the 2at.% Tm$^{3+}$ doped rod. On the other hand the 6at.% Tm$^{3+}$ doped rod had a ~1.5 times higher threshold indicating that ETU has a very significant impact on its performance. In the case of the two higher doping concentrations the maximum output powers were limited by stress fracture. This is expected to be the case for the 2at.% doped crystal as well and an estimation of the maximum pump power can be calculated from the comparative parameters reported here.
Fig. 2. Tm:YLF laser performance for various doping concentrations for (a) diode-bar and (b) diode-stack pumping.

An approximate value for the stress-fracture pump power limit can be obtained by comparing the thermal load per unit length for the three doping concentrations. The maximum stress, $\sigma_{\text{max}}$, which YLF can tolerate in an end-pumped configuration before fracture occurs is dependent upon its material parameters, the pump beam size and the rod diameter [6]. The variable parameters for comparison here are the absorption length, $\alpha_{\text{abs}}$ and the total maximum heat load, $P_{h_{\text{max}}}$:

$$\sigma_{\text{max}} \propto \alpha_{\text{abs}} P_{h_{\text{max}}}$$  \hspace{1cm} (1)

where $P_h$ is the power converted to heat when the pump power exceeds that required for threshold, and is given by:

$$P_h = (1 - \eta_{QY} \eta_{St})(P_{abs} - P_{ETU}) + P_{ETU}$$  \hspace{1cm} (2)

where $\eta_{QY}$ is the quantum yield, $\eta_{St}$ the Stokes efficiency, $P_{ETU}$ the amount of absorbed power channelled into ETU, which is clamped at threshold and is totally transferred to the crystal lattice as heat, and $P_{abs}$ the absorbed pump power. At this point an estimation of the quantum yield as a function of doping concentration is required, which has been calculated (Fig. 3) following the method of Honea et al. [7], where the reported Tm:YLF lifetime measurements by Armagan et al. [8] for various doping concentrations and the $^3F_4 \rightarrow ^3H_4$ branching ratio after Walsh et al. [9] have been used. The ratio of the predicted quantum yield values for 2 and 4at.% Tm (see Fig. 3) and the measured slope efficiencies are in good agreement. Therefore we can be confident in utilising the predicted quantum yield values to estimate the maximum heat load for the various doping concentrations investigated. The method employed is as follows, first one has to evaluate the threshold pump power that would be expected in the absence of ETU. This is achieved by simply scaling the threshold pump power measured for the 2at.% crystal by the ratio of 1.8, the quantum yield for 2at.%, with the quantum yield for the doping concentration of interest. The difference between the measured threshold power and the predicted threshold pump power without ETU represents $P_{ETU}$. Note it is necessary to assume $P_{ETU}$ is negligible for 2at.% Tm with respect to the threshold pump power, such an assumption is warranted noting the small difference in threshold between 2 and 4at.% Tm in contrast to that for 6at.% Tm.

Equation (2) and the parameters listed in Table 1, give the heating power per unit absorption length as presented in Fig. 4. The predicted maximum incident pump power, for the configuration detailed here, at which crystal fracture is predicted to occur for each doping concentration is indicated in the final column of Table 1. It has been assumed; (a) the threshold absorption efficiency was that for the
diode-bar pumping experiments, (b) there was negligible ETU for 2at.% Tm, thus enabling the estimation of the threshold power without ETU for each doping level, and (c) the calculated thermal load at which the 6at.% crystal failed, ~13W/cm, is a benchmark for the other crystals.

Table 1. Comparison summary of the parameters used to calculate the thermal loading in the diode-bar pumped Tm:YLF

<table>
<thead>
<tr>
<th>Doping conc. (At.%)</th>
<th>P_{th} meas. (W)</th>
<th>\eta_{QY} predicted</th>
<th>P_{th} estim. without ETU</th>
<th>P_{ETU} (W)</th>
<th>\alpha_{abs}P_{th} @ P_{inc} for 6At.% (W/cm)</th>
<th>Predicted P_{inc} limit (W)</th>
</tr>
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<tbody>
<tr>
<td>2</td>
<td>7.2</td>
<td>1.8</td>
<td>7.2</td>
<td>-0</td>
<td>3.6</td>
<td>74.6</td>
</tr>
<tr>
<td>4</td>
<td>6.8</td>
<td>1.95</td>
<td>6.6</td>
<td>0.13</td>
<td>5.6</td>
<td>48.5</td>
</tr>
<tr>
<td>6</td>
<td>9.7</td>
<td>1.97</td>
<td>6.6</td>
<td>2.6</td>
<td>13.0</td>
<td>20.5 (meas.)</td>
</tr>
</tbody>
</table>

* Note the absorption efficiency of 82% has been included here.

Fig. 3. Estimated quantum yield versus Tm concentration. \( \tau_0 \) is the un-quenched lifetime of the \( ^3\!F_4 \) manifold, \( C_0 \) a characteristic doping concentration, and \( \beta \) the branching ratio for \( ^3\!F_4 \rightarrow ^3\!H_4 \) [7-9].

Considering Fig. 4, it is important to note that equation (2) is valid only above threshold, i.e. when \( P_{ETU} \) is clamped, below threshold both the quantum defect heating and heating due to upconversion vary with pump power and would tend to zero for no incident pump power. Comparing the measured incident pump power at which fracture was observed for 4at.% Tm, i.e. 45.8W (Fig.2(b)), with the predicted value, 48.5W (Fig. 4.), we see that there is good agreement. Further support of this method is found when accounting for the higher threshold condition measured for diode-stack pumping, Fig 2(b). The higher threshold was attributed to the difference in the absorption efficiency and pump distribution within the Tm:YLF crystals for the two pump sources. As such a thermal load per absorption length of 13W/cm, corresponding to the 6at.% fracture limit, is calculated for the 4at.% crystal, which corresponds to an incident power of 45W and is in excellent agreement with the measured value of fracture-limit of 45.8W for diode-stack pumping. This provides a good level of confidence for the predicted maximum pump power limit for the 2at.% Tm:YLF crystal of 75W, which could generate ~25W of output power from a single standard single-end-pumped rod.

Conclusions

A comparison of laser performance for various doping concentrations of Tm:YLF has been reported. For the end-pumped configuration described, a thermal load per absorption length of ~13W/cm represents
the stress-fracture limit for Tm:YLF rods. Consequently at the few tens of Watts pump power levels, the 4at.% Tm:YLF rod offered the best performance in terms of maximum output power and overall efficiency. However, despite having a ~10% lower quantum yield, the 2at.% Tm:YLF crystal, by virtue of a lower thermal loading density and therefore a much higher fracture-limit at the pump wavelength of ~792nm, appears to offer better prospects for end-pumped power scaling.

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References


